

Substitute for form 1449/PTO				<i>Complete if Known</i>	
				Application Number	10/764,532-Conf. #4091
				Filing Date,	January 27, 2004
				First Named Inventor	Yasuyuki SHIRASAKA
				Art Unit	2815
				Examiner Name	M. B. Shingleton
Sheet	1	of	1	Attorney Docket Number	1248-0691P

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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FOREIGN PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Foreign Patent Document Country-Code*-Number*-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
/MBS/	BA	JP-2002-319827	10-31-2002	Matsushita Electric Ind Co Ltd	
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Examiner Signature	/Michael B Shingleton/	Date Considered	June 11, 2008
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NON PATENT LITERATURE DOCUMENTS			
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